AMENDMENTS TO THE CLAIMS

1. (Currently Amended) An array substrate for a liquid crystal display device, comprising:

a substrate;

gate and data lines crossing each other on the substrate;

a thin film transistor connected to the gate and data lines, the thin film transistor having a gate electrode, a semiconductor layer, and source and drain electrodes facing and spaced apart from each other;

a passivation layer over the gate and data lines and the thin film transistor, the passivation layer having a contact hole exposing a portion of a side surface of the drain electrode;

a gate insulation layer formed underneath the passivation layer, wherein the contact hole is defined through the passivation layer and the gate insulation layer; and

a pixel electrode on the passivation layer; and

a storage capacitor including a portion of the gate line as a first storage electrode, a portion of the gate insulation layer, and a second storage electrode having an island shape, wherein the first storage electrode is formed of the same material as the gate electrode and the second storage electrode is formed of the same material as the source and drain electrodes and disposed on the gate insulation layer.

Appl. No. 10/028,667 Docket No. 3430-0172P Amendment filed February 26, 2004 Page 3 of 14

Office Action dated November 26, 2003

2. (Previously Presented) The array substrate according to claim 1, wherein

the pixel electrode is electrically connected to the drain electrode through the

contact hole, and also contacts the substrate through the contact hole.

3. (Canceled)

4. (Canceled)

5. (Original) The array substrate according to claim 1, wherein the contact

hole further exposes a portion of a top surface of the drain electrode.

6. (Currently Amended) An array substrate for a liquid crystal display

device, comprising:

a substrate;

gate and data lines crossing each other on the substrate;

a thin film transistor connected to the gate and data lines, the thin film

transistor having a gate electrode extending from the gate line, a semiconductor

layer, a first ohmic contact layer, a second ohmic contact layer, and source and

drain electrodes, the semiconductor layer having an end aligned with and directly

Appl. No. 10/028,667 Docket No. 3430-0172P Amendment filed February 26, 2004 Page 4 of 14

Office Action dated November 26, 2003

below an end of the source electrode, the semiconductor layer having an opposite

end aligned with and directly below an end of the drain electrode;

a passivation layer pattern on the data line and the thin film transistor, the

passivation layer pattern exposing a portion of a side surface of the drain

electrode; and

a pixel electrode connected to the drain electrode; and

a gate insulation film formed over the gate line, wherein a portion of the

pixel electrode is formed directly on the gate insulation film in a whole of a pixel

region defined by the gate and data lines.

7. (Previously Presented) The array substrate according to claim 6, further

comprising a storage capacitor including a first storage electrode, a portion of a

gate insulation layer, and a second storage electrode, wherein the first storage

electrode is formed of the same material as the gate electrode and the second

storage electrode is formed of the same material as the source and drain electrode,

and wherein the pixel electrode contacts the second storage electrode through a

contact hole formed through the passivation layer.

8. (Previously Presented) The array substrate according to claim 6, wherein

the first ohmic contact layer has an end aligned with and directly below the end of

Appl. No. 10/028,667 Amendment filed February 26, 2004

Office Action dated November 26, 2003

Docket No. 3430-0172P

Page 5 of 14

the source electrode and the second ohmic contact layer has an end aligned with

and directly below the end of the drain electrode.

9. (Original) The array substrate according to claim 6, wherein the

passivation layer pattern exposes a portion of one side surface of the drain

electrode.

10. (Canceled)

11. (Original) The array substrate according to claim 6, wherein the

passivation layer pattern further exposes a portion of a top surface of the drain

electrode.

12. (Previously Presented) An array substrate for a display device,

comprising:

a substrate;

a gate line on the substrate;

a gate insulator on the gate line;

a semiconductor layer on the gate insulator;

a first ohmic contact layer and a second ohmic contact layer on the

semiconductor layer;

Docket No. 3430-0172P Page 6 of 14

Appl. No. 10/028,667 Amendment filed February 26, 2004 Office Action dated November 26, 2003

a data line and source and drain electrodes on the plurality of ohmic contact layers, the source electrode connected to the data line, the drain electrode facing and spaced apart from the source electrode;

a passivation layer on the source and drain electrodes and covering a crossing portion of the gate and data lines, a portion of a side surface of the drain electrodes being exposed; and

a pixel electrode connected to the drain electrode; and

a gate insulation film formed over the gate line, wherein a portion of the pixel electrode is formed directly on the gate insulation film in a whole of a pixel region defined by the gate and data lines,

wherein the first ohmic contact layer has an end aligned with and directly below an end of the source electrode and the second ohmic contact layer has an end aligned with and directly below an end of the drain electrode, and

wherein the semiconductor layer has an end aligned with and directly below the end of the source electrode, and an opposite end aligned with and directly below the end of the drain electrode.

13. (Currently Amended) The array substrate according to claim 12, wherein a portion of the pixel electrode is formed directly on the gate insulator in a whole of a pixel region defined by the gate and data lines.

Office Action dated November 26, 2003

14. (Previously Presented) The array substrate according to claim 12,

wherein the passivation layer exposes a portion of a top surface of the drain

electrode.

15. (Withdrawn) A fabricating method of an array substrate for a liquid

crystal display device, comprising:

forming a gate line on a substrate;

forming an ohmic contact layer on the substrate;

forming a data line and source and drain electrodes on the ohmic contact

layer, the source electrode being connected to the data line, the source and drain

electrodes facing and spaced apart from each other;

forming a passivation layer having a contact hole on the data line and the

source and drain electrodes, the contact hole exposing a portion of a side surface

of the drain electrode; and

forming a pixel electrode on the passivation layer, the pixel electrode being

connected to the drain electrode through the contact hole.

16. (Withdrawn) The fabricating method according to claim 15, wherein the

ohmic contact layer, the data line, and the source and drain electrodes are formed

using a single mask.

Docket No. 3430-0172P Page 8 of 14

Appl. No. 10/028,667 Amendment filed February 26, 2004 Office Action dated November 26, 2003

17. (Withdrawn) The fabricating method according to claim 15, wherein the contact hole exposes a portion of a top surface of the drain electrode.

18. (Withdrawn) The fabricating method according to claim 15, further comprising:

forming a gate insulator on the gate line and under the passivation layer, wherein the contact hole is defined through the passivation layer and the gate insulator.

19. (Withdrawn) A fabricating method of an array substrate for a liquid crystal display device, comprising:

forming a gate line on a substrate using a first mask;

subsequently depositing a gate insulator, an amorphous silicon layer, a doped amorphous silicon layer and a conductive layer on the gate line;

forming a semiconductor layer, a plurality of ohmic contact layers, a data line, and source and drain electrodes using a second mask;

forming a passivation layer pattern on the source and drain electrodes using a third mask, the passivation layer pattern covering a crossing portion of the gate and the data lines and exposing a portion of a side surface of the drain electrode; and

Appl. No. 10/028,667 Amendment filed February 26, 2004

Office Action dated November 26, 2003

Docket No. 3430-0172P

Page 9 of 14

forming a pixel electrode connected to the drain electrode using a fourth

mask.

20. (Withdrawn) The fabricating method according to claim 19, wherein the

passivation layer pattern further exposes a portion of a top surface of the drain

electrode.

21. (Withdrawn) The fabricating method according to claim 19, further

comprising:

forming a gate insulator over the gate line, wherein a portion of the pixel

electrode is formed directly on the gate insulator.

22. (Previously Presented) The array substrate according to claim 12, further

comprising a storage capacitor including a first storage electrode, a portion of the

gate insulator, and a second storage electrode, wherein the pixel electrode contacts

the second storage electrode through a contact hole formed through the passivation

layer, and wherein the first storage electrode is formed of the same material as the

gate electrode and the second storage electrode is formed of the same material as the

source and drain electrodes.